

Micropower Temperature, Power Supply and Differential Voltage Monitor

July 1995

FEATURES

- Complete Ambient Temperature Sensor Onboard
- Power Supply Monitor
- 10-Bit Resolution Rail-to-Rail Common-Mode Differential Voltage Input
- Available in 8-Pin SO
- 0.2 μ A Supply Current When Idle
- 350 μ A Supply Current When Converting
- Single Supply Voltage: 4.5V to 6V
- Three-Wire Half-Duplex Serial I/O
- Communicates with Most MPU Serial Ports and All MPU Parallel I/O Ports

APPLICATIONS


- Temperature Measurement
- Power Supply Measurement
- Current Measurement
- Remote Data Acquisition

DESCRIPTION

The LTC[®]1392 is a micropower data acquisition system designed to measure temperature, on-chip supply voltage and differential rail-to-rail common-mode voltage. The device features a temperature sensor, a 10-Bit A/D converter with sample-and-hold, a high accuracy bandgap reference and a three-wire half-duplex serial interface.

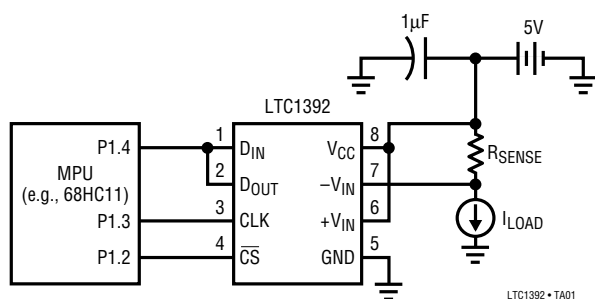
The LTC1392 can be programmed to measure ambient temperature, power supply voltage and external voltage at the differential input pins, which can be used for current measurement. When measuring temperature, the output code of the A/D converter is linearly proportional to the temperature in $^{\circ}$ Celsius. Wafer level trimming achieves $\pm 2^{\circ}$ C initial accuracy at room temperature and $\pm 4^{\circ}$ C over the full -40° C to 85° C temperature range.

The on-chip serial port allows efficient data transfer to a wide range of MPUs over three wires. This, coupled with low power consumption, makes remote location sensing possible and facilitates transmitting data through isolation barriers.

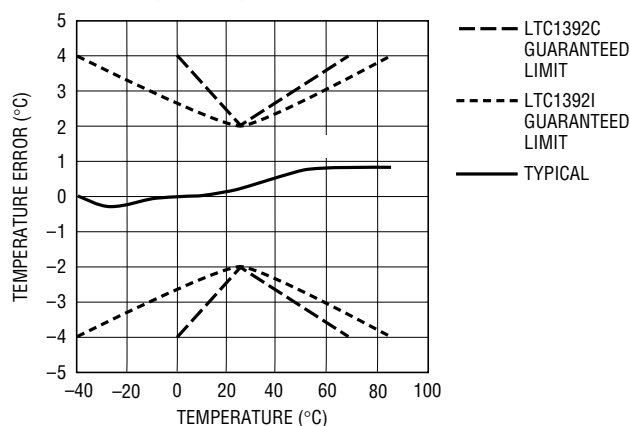
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TYPICAL APPLICATION

Complete Temperature, Supply Voltage and
Supply Current Monitor



Output Temperature Error



LTC1392 • TA02

ABSOLUTE MAXIMUM RATINGS

(Note 1)

Supply Voltage (V_{CC})	7V
Input Voltage	$-0.3V$ to $V_{CC} + 0.3V$
Output Voltage	$-0.3V$ to $V_{CC} + 0.3V$
Operating Temperature Range	
Commercial	$0^{\circ}C$ to $70^{\circ}C$
Industrial	$-40^{\circ}C$ to $85^{\circ}C$
Junction Temperature	$150^{\circ}C$
Storage Temperature Range	$-65^{\circ}C$ to $150^{\circ}C$
Lead Temperature (Soldering, 10 sec)	$300^{\circ}C$

PACKAGE/ORDER INFORMATION

<p>N8 PACKAGE 8-LEAD PDIP</p> <p>S8 PACKAGE 8-LEAD PLASTIC SO</p> <p>$T_{JMAX} = 150^{\circ}C$, $\theta_{JA} = 100^{\circ}C/W$ (N8) $T_{JMAX} = 150^{\circ}C$, $\theta_{JA} = 150^{\circ}C/W$ (S8)</p>	ORDER PART NUMBER
	LTC1392CN8 LTC1392CS8 LTC1392IN8 LTC1392IS8
	S8 PART MARKING
	1392 13921

Consult factory for Military grade parts.

ELECTRICAL CHARACTERISTICS (Note 3)

PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
Power Supply To Digital Conversion					
Resolution	$V_{CC} = 4.5V$ to $6V$			10	Bit
Total Absolute Error	$V_{CC} = 4.5V$ to $6V$, $0^{\circ}C \leq T_A \leq 70^{\circ}C$			± 5	LSB
	$V_{CC} = 4.5V$ to $6V$, $-40^{\circ}C \leq T_A \leq 85^{\circ}C$			± 8	LSB
Differential Voltage to Digital Conversion (Full-Scale Input = 1V)					
Resolution				10	Bit
Integral Linearity Error (Note 5)		●	± 2		LSB
Differential Linearity Error		●	± 1		LSB
Offset Error		●	± 4		LSB
Full-Scale Error		●		± 10	LSB
Input Referred Noise			± 1		LSB _{RMS}
Differential Voltage to Digital Conversion (Full-Scale Input = 0.5V)					
Resolution				10	Bit
Integral Linearity Error (Note 5)		●	± 4		LSB
Differential Linearity Error		●	± 2		LSB
Offset Error		●	± 8		LSB
Full-Scale Error		●		± 20	LSB
Input Referred Noise			± 2		LSB _{RMS}
Temperature to Digital Conversion (LTC1392)					
Accuracy	$T_A = 25^{\circ}C$ (Note 7)	●		± 2	$^{\circ}C$
	$T_A = T_{MAX}$ or T_{MIN} (Note 7)	●		± 4	$^{\circ}C$
Nonlinearity	$T_{MIN} \leq T_A \leq T_{MAX}$ (Note 4)		± 1		$^{\circ}C$

ELECTRICAL CHARACTERISTICS (Note 3)

SYMBOL	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
$I_{ON\ LEAKAGE}$	On-Channel Leakage Current (Note 6)		●		±1	μA
$I_{OFF\ LEAKAGE}$	Off-Channel Leakage Current (Note 6)		●		±1	μA
V_{IH}	High Level Input Voltage	$V_{CC} = 5.25V$	●	2		V
V_{IL}	Low Level Input Voltage	$V_{CC} = 4.75V$	●		0.4	V
I_{IH}	High Level Input Current	$V_{IN} = V_{CC}$	●		5	μA
I_{IL}	Low Level Input Current	$V_{IN} = 0V$	●		−5	μA
V_{OH}	High Level Output Voltage	$V_{CC} = 4.75V, I_{OUT} = 10\mu A$ $V_{CC} = 4.75V, I_{OUT} = 360\mu A$	●	4.5 2.4	4.74 4.72	V V
V_{OL}	Low Level Output Voltage	$V_{CC} = 4.75V, I_{OUT} = 1.6mA$	●		0.4	V
I_{OZ}	Hi-Z Output Current	\overline{CS} High	●		±5	μA
I_{SOURCE}	Output Source Current	$V_{OUT} = 0V$		−25		mA
I_{SINK}	Output Sink Current	$V_{OUT} = V_{CC}$		45		mA
I_{CC}	Supply Current	\overline{CS} High $t_{CYC} = 76\mu s, f_{CLK} = 250kHz$	●	0.1 300	5 500	μA μA
t_{SMPL}	Analog Input Sample Time	See Figure 1		1.5		CLK Cycles
t_{CONV}	Conversion Time	See Figure 1		10		CLK Cycles
t_{dDO}	Delay Time, $CLK\downarrow$ to D_{OUT} Data Valid	$C_{LOAD} = 100pF$	●	150	300	ns
t_{en}	Delay Time, $CLK\downarrow$ to D_{OUT} Data Enabled	$C_{LOAD} = 100pF$	●	60	150	ns
t_{dis}	Delay Time, $\overline{CS}\uparrow$ to D_{OUT} Hi-Z		●	170	450	ns
t_{hDO}	Time Output Data Remains Valid After $CLK\downarrow$	$C_{LOAD} = 100pF$		30		ns
t_f	D_{OUT} Fall Time	$C_{LOAD} = 100pF$	●	70	250	ns
t_r	D_{OUT} Rise Time	$C_{LOAD} = 100pF$	●	25	100	ns
C_{IN}	Input Capacitance	Analog Input On-Channel		30		pF
		Analog Input Off-Channel		5		pF
		Digital Input		5		pF

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
V_{CC}	Supply Voltage		4.5		6	V
f_{CLK}	Clock Frequency	$V_{CC} = 5V$	50		250	kHz
t_{CYC}	Total Cycle Time	$f_{CLK} = 250kHz$ Temperature Conversion Only	74 144			μs μs
t_{hDI}	Hold Time, D_{IN} After $CLK\uparrow$	$V_{CC} = 5V$	150			ns
$t_{su\overline{CS}}$	Setup Time $\overline{CS}\downarrow$ Before First $CLK\uparrow$ (See Figure 1)	$V_{CC} = 5V$	2			μs
t_{WAKEUP}	Wakeup Time $\overline{CS}\downarrow$ Before Start Bit \uparrow (See Figure 1)	$V_{CC} = 5V$ Temperature Conversion Only	10 80			μs μs
t_{suDI}	Setup Time, D_{IN} Stable Before $CLK\uparrow$	$V_{CC} = 5V$	150			ns
t_{WHCLK}	Clock High Time	$V_{CC} = 5V$	1.6			μs
t_{WLCLK}	Clock Low Time	$V_{CC} = 5V$	2			μs
$t_{WH\overline{CS}}$	\overline{CS} High Time Between Data Transfer Cycles	$V_{CC} = 5V, f_{CLK} = 250kHz$	2			μs
$t_{WL\overline{CS}}$	\overline{CS} Low Time During Data Transfer	$V_{CC} = 5V, f_{CLK} = 250kHz$ Temperature Conversion Only	72 142			μs μs

RECOMMENDED OPERATING CONDITIONS

The ● denotes specifications which apply over the operating temperature range ($0^{\circ}\text{C} \leq T_A \leq 70^{\circ}\text{C}$ for commercial grade and $-40^{\circ}\text{C} \leq T_A \leq 85^{\circ}\text{C}$ for industrial grade).

Note 1: Absolute maximum ratings are those values beyond which the life of the device may be impaired.

Note 2: All voltage values are with respect to GND.

Note 3: Testing done at $V_{CC} = 5\text{V}$, $\text{CLK} = 250\text{kHz}$ and $T_A = 25^{\circ}\text{C}$ unless otherwise specified.

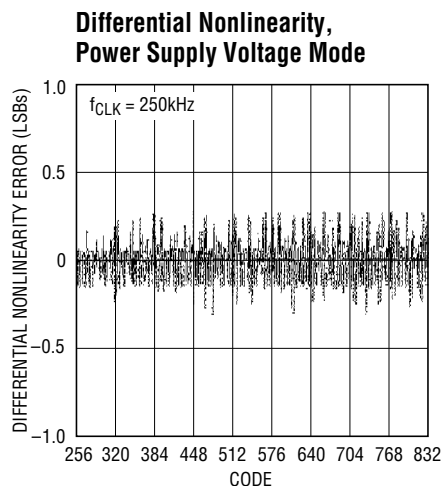
Note 4: Temperature integral nonlinearity is defined as the deviation of the A/D code versus temperature curve from the best-fit straight line over the device's rated temperature range.

Note 5: Voltage integral nonlinearity is defined as the deviation of a code from a straight line passing through the actual end points of the transfer curve.

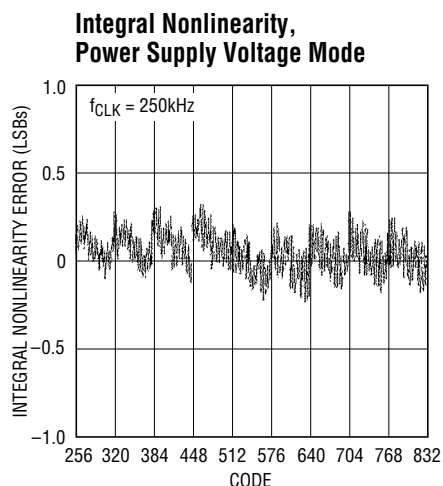
Note 6: Channel leakage current is measured after the channel selection.

Note 7: See guaranteed temperature limit curves vs temperature range on the first page of this data sheet.

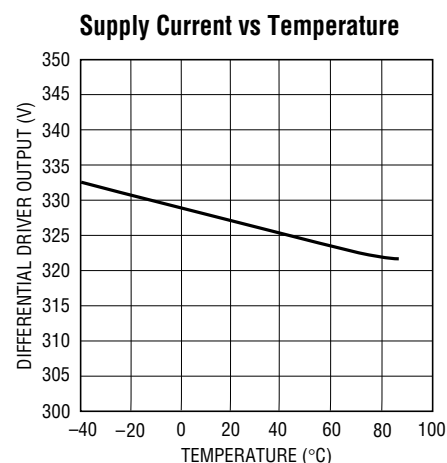
TYPICAL PERFORMANCE CHARACTERISTICS



LTC1392 • G01



LTC1392 • G02



LTC1392 • G03

PIN FUNCTIONS

D_{IN} (Pin 1): Digital Input. The A/D configuration word is shifted into this input.

D_{OUT} (Pin 2): Digital Output. The A/D result is shifted out of this output.

CLK (Pin 3): Shift Clock. This clock synchronizes the serial data.

$\overline{\text{CS}}$ (Pin 4): Chip Select Input. A logic low on this input enables the LTC1392.

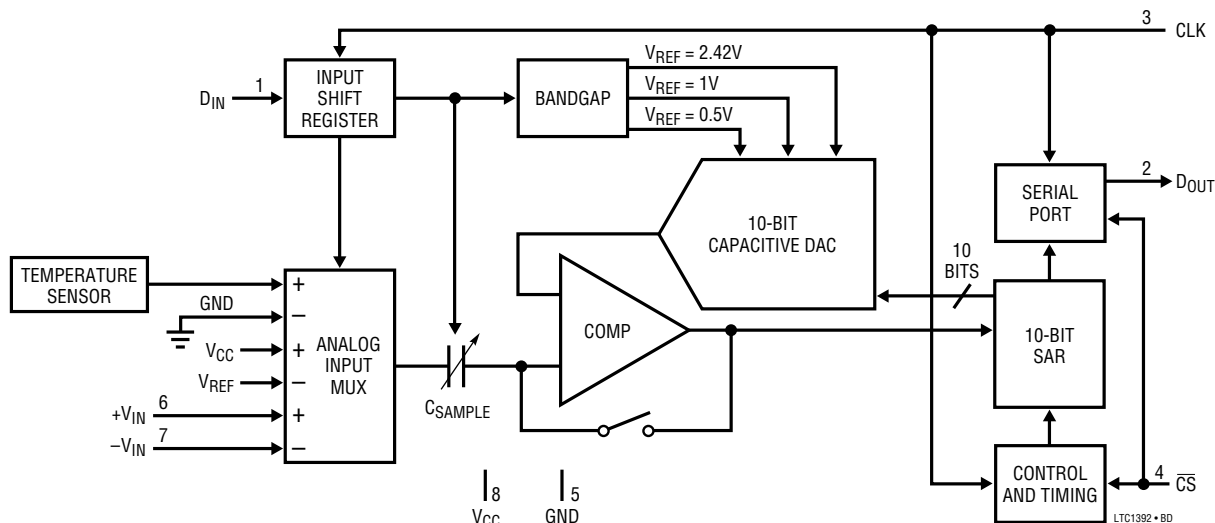
GND (Pin 5): Ground Pin. GND should be tied directly to an analog ground plane.

+V_{IN} (Pin 6): Positive Analog Differential Input. The pin can be used as a single-ended input by grounding $-V_{\text{IN}}$.

$-V_{\text{IN}}$ (Pin 7): Negative Analog Differential Input. The input must be free from noise.

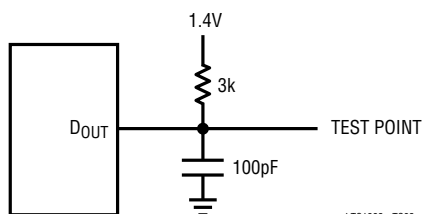
V_{CC} (Pin 8): Positive Supply. This supply must be kept free from noise and ripple by bypassing directly to the ground plane.

BLOCK DIAGRAM

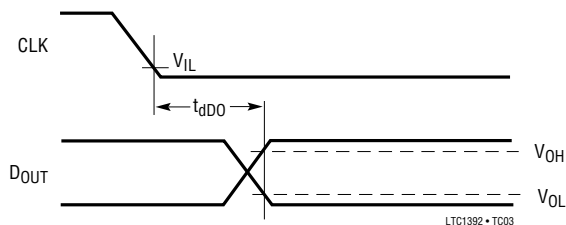


TEST CIRCUITS

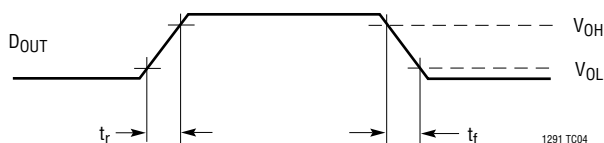
Load Circuit for t_{dD0} , t_r and t_f



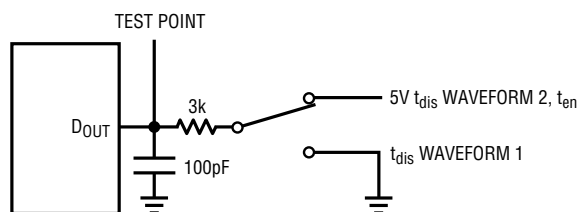
Voltage Waveforms for D_{OUT} Delay Time, t_{dpo}



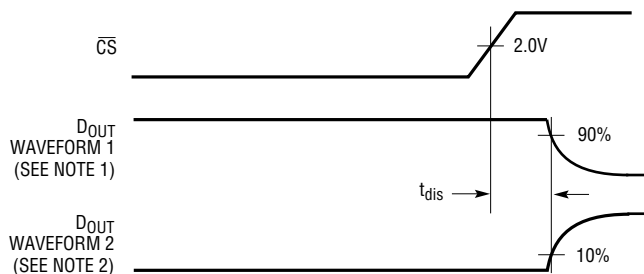
Voltage Waveforms for D_{OUT} Rise and Fall Times, t_r and t_f



Load Circuit for t_{dis} and t_{en}



Voltage Waveforms for t_{dis}



NOTE 1: WAVEFORM 1 IS FOR AN OUTPUT WITH INTERNAL CONDITIONS SUCH THAT THE OUTPUT IS HIGH UNTIL DISABLED BY THE OUTPUT CONTROL.
NOTE 2: WAVEFORM 2 IS FOR AN OUTPUT WITH INTERNAL CONDITIONS SUCH THAT THE OUTPUT IS LOW UNTIL DISABLED BY THE OUTPUT CONTROL.

APPLICATIONS INFORMATION

The LTC1392 is a micropower data acquisition system designed to measure temperature, on-chip power supply voltage and differential input voltage. The LTC1392 contains the following functional blocks:

1. On-chip temperature sensor
2. 10-bit successive approximation capacitive ADC
3. Bandgap reference
4. Analog multiplexer (MUX)
5. Sample-and-hold (S/H)
6. Synchronous, half-duplex serial interface
7. Control and timing logic

DIGITAL CONSIDERATIONS

Serial Interface

The LTC1392 communicates with microprocessors and other external circuitry via a synchronous, half-duplex, three-wire serial interface (see Figure 1). The clock (CLK) synchronizes the data transfer with each bit being transmitted on the falling CLK edge and captured on the rising CLK edge in both transmitting and receiving systems. The input data is first received and then the A/D conversion result is transmitted (half-duplex). Half-duplex operation allows D_{IN} and D_{OUT} to be tied together allowing transmission over three wires: \overline{CS} , CLK and DATA (D_{IN}/D_{OUT}). Data transfer is initiated by a falling chip select (\overline{CS}) signal. After the falling \overline{CS} is recognized, an 80 μ s delay is needed for temperature measurement or a 10 μ s delay for other measurements, followed by a 4-bit input word which configures the LTC1392 for the current conversion. This data word is shifted into the D_{IN} input. D_{IN} is then disabled from shifting in any data and the D_{OUT} pin is configured from three-state to an output pin. A null bit and the result of the current conversion are serially transmitted on the falling CLK edge onto the D_{OUT} line. The format of the A/D result can be either MSB-first sequence or LSB-first sequence followed by an LSB-first sequence. This provides easy interface to MSB- or LSB-first serial ports. Bringing \overline{CS} high resets the LTC1392 for the next data exchange.

INPUT DATA WORD

The LTC1392 4-bit input word is clocked into the D_{IN} input on the first four rising CLK edges after \overline{CS} is recognized. Further inputs on the D_{IN} input are then ignored until the next \overline{CS} cycle. The four bits of the input word are defined as follows:

BIT 3	BIT 2	BIT 1	BIT 0
Start	Select 1	Select 0	MSBF

Start Bit

The first "logic one" clocked into the D_{IN} input after \overline{CS} goes low is the Start Bit. The Start Bit initiates the data transfer and all leading zeros which precede this logical one will be ignored. After the Start Bit is received the remaining bits of the input word will be clocked in. Further input on the D_{IN} pin are then ignored until the next \overline{CS} cycle.

Measurement Modes Selection

The two bits of the input word following the Start Bit assign the measurement mode for the requested conversion. Table 1 shows the modes selection. Whenever there is a mode change from another mode to temperature measurement, a temperature mode initializing cycle is needed. The first temperature data measurement after a mode change should be ignored.

Table 1. Measurement Modes Selection

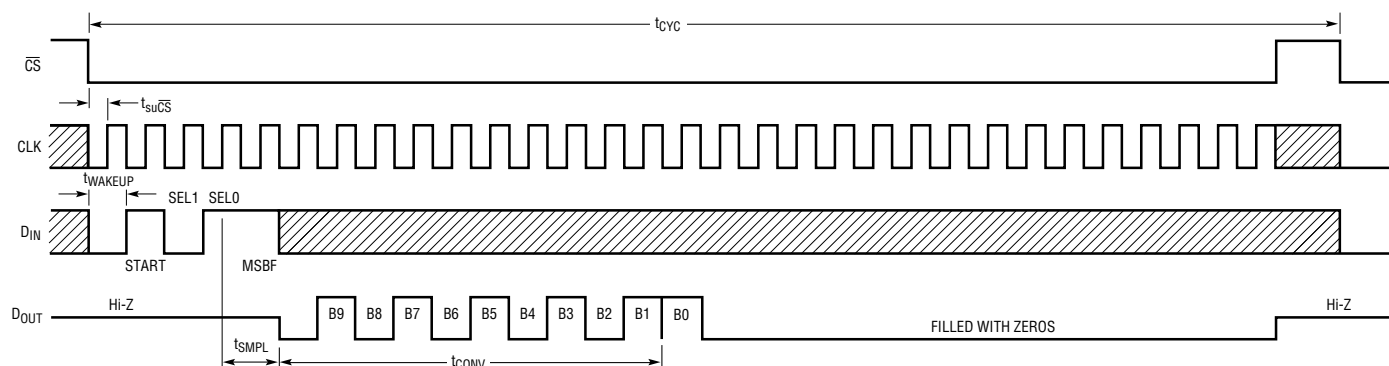
SELECT 1	SELECT 0	MEASUREMENT MODE
0	0	Temperature
0	1	Power Supply Voltage
1	0	Differential Input, 1V Full Scale
1	1	Differential Input, 0.5V Full Scale

MSB-First/LSB-First (MSBF)

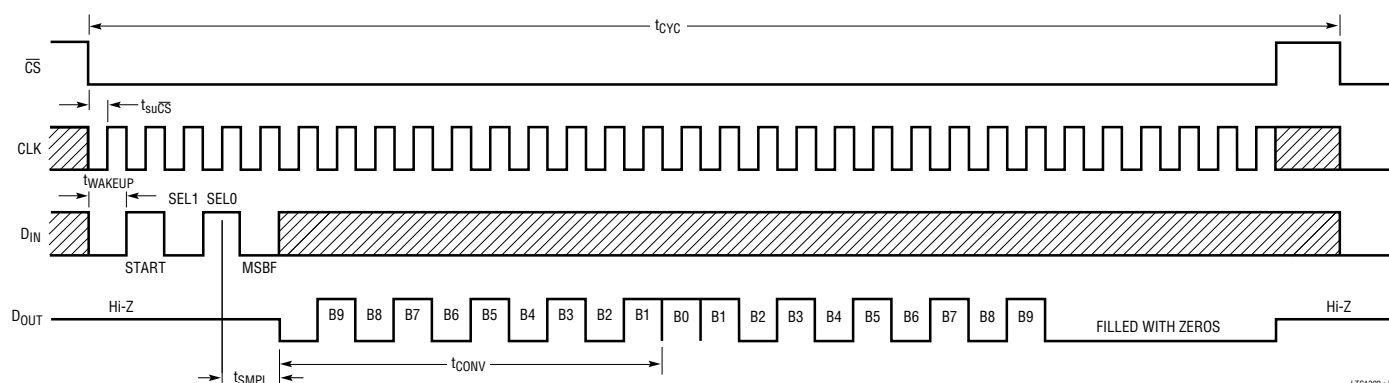
The output data of the LTC1392 is programmed for MSB-first or LSB-first sequence using the MSBF bit. When the MSBF bit is a logical one, data will appear on the D_{OUT}

APPLICATIONS INFORMATION

MSB-First Data (MSBF = 1)



MSB-First Data (MSBF = 0)



LTC1392 • F01

Figure 1.

line in MSB-first format. Logical zeros will be filled in indefinitely following the last data bit to accommodate longer word lengths required by some microprocessors. When the MSBF bit is a logical zero, LSB-first data will follow the normal MSB-first data on the D_{OUT} line.

CONVERSIONS

Temperature Conversion

The LTC1392 measures temperature through the use of an on-chip, proprietary temperature measurement technique. The temperature reading is provided in a 10-bit, unipolar format. Table 2 describes the exact relationship of output data to measured temperature or equation 1 can be used to calculate the temperature.

$$\text{Temperature (}^{\circ}\text{C)} = \text{Output Code}/4 - 130 \quad (1)$$

Note that the LTC1392I is only specified for use over the -40°C to 85°C operating temperature range. Temperature outside this range may have errors greater than those shown in the electrical characteristic table.

Table 2. Codes for Temperature Conversion

OUTPUT CODE	TEMPERATURE ($^{\circ}\text{C}$)
1111111111	125.75
1111111110	125.50
...	...
1001110101	27.25
1001110100	27.00
1001110011	26.75
...	...
0000000001	-129.75
0000000000	-130.00

APPLICATIONS INFORMATION

Voltage Supply (V_{CC}) Monitor

The LTC1392 measures supply voltage through the on-chip V_{CC} supply line. The V_{CC} reading is provided in a 10-bit, unipolar format. Table 3 describes the exact relationship of output data to measured V_{CC} or equation (2) can be used to calculate the measured V_{CC} .

$$\begin{aligned} \text{Measured } V_{CC} = \\ (7.26 - 2.42) \times \text{Output Code}/1024 + 2.42 \end{aligned} \quad (2)$$

The guaranteed supply voltage monitor range is from 4.5V to 6V. Typical parts are able to maintain the measurement accuracy with V_{CC} as low as 3.25V. The typical INL and DNL error plots shown on page 4 are measured with V_{CC} from 3.63V to 6.353V.

Table 3. Codes for Voltage Supply Conversion

OUTPUT CODE	Supply Voltage (V_{CC})
1011110110	6.003V
1011110101	5.998V
...	...
1000100010	5.001V
...	...
0110111001	4.504V
0110111000	4.500V

Differential Voltage Conversion

The LTC1392 measures the differential input voltage through pins $+V_{IN}$ and $-V_{IN}$. Input ranges of 0.5V or 1V full scale are available for differential voltage measurement

with resolutions of 10 bits. Tables 4a and 4b describe the exact relationship of output data to measured differential input voltage in the 1V and 0.5V input range. Equations (3) and (4) can be used to calculate the differential voltage in the 1V and 0.5V input voltage range respectively. The output code is in unipolar format.

$$\text{Differential Voltage} = 10\text{-bit code}/1024 \quad (3)$$

$$\text{Differential Voltage} = 0.5 \times (10\text{-bit code})/1024 \quad (4)$$

Table 4a. Codes for 1V Differential Voltage Range

OUTPUT CODE	INPUT VOLTAGE	INPUT RANGE = 1V	REMARKS
1111111111	1V – 1LSB	999.0mV	
1111111110	1V – 2LSB	998.0mV	
...	
0000000001	1LSB	0.977mV	1LSB = 1/1024
0000000000	0LSB	0.00mV	

Table 4b. Codes for 0.5V Differential Voltage Range

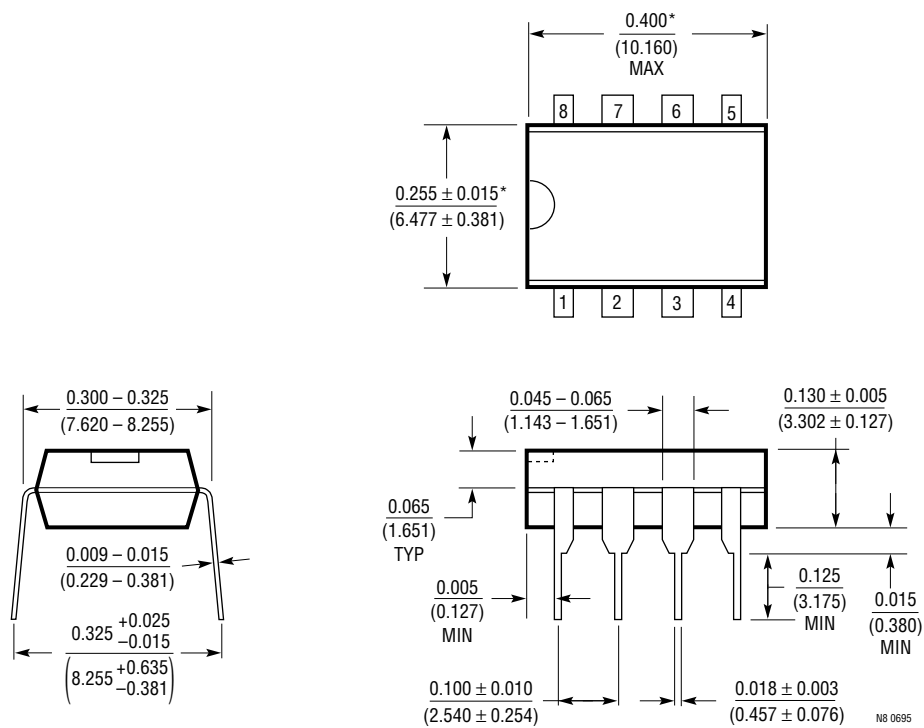
OUTPUT CODE	INPUT VOLTAGE	INPUT RANGE = 0.5V	REMARKS
1111111111	0.5V – 1LSB	499.0mV	
1111111110	0.5V – 2LSB	498.1mV	
...	
0000000001	1LSB	0.488mV	1LSB = 0.5/1024
0000000000	0LSB	0.00mV	

The schematic diagram illustrates the internal circuitry of the LTC1392 evaluation board. It features a -5V supply connected to a 470Ω resistor, which is in series with a 1k 1% resistor and a 500Ω 90% RH TRIM. This network is connected to an LT1004 1.2V diode. The output of the diode is connected to a 1μF capacitor and a 1/4 LTC1043 switch. The switch is controlled by a 5V supply and is connected to a SENSOR (Panametrics #RHS) and a 22M resistor. The output of the sensor is connected to a 10k 5% RH TRIM and a 33k resistor. The output of the 33k resistor is connected to the non-inverting input of an LT®1056 op-amp. The op-amp is configured with a 0.01μF capacitor and a 100pF capacitor. The output of the LT®1056 is connected to the non-inverting input of an LM301A op-amp. The LM301A is configured with a 10k resistor and a 0.1μF capacitor. The output of the LM301A is connected to a 9k 1% resistor and a 1k 1% resistor. The output of the 1k 1% resistor is connected to the LTC1392. The LTC1392 is connected to an MPU (e.g., 8051) via P1.4, P1.3, and P1.2. The LTC1392 also has a 5V supply and a 0.1μF capacitor connected to its VCC pin. The LTC1392 is labeled with the part number LTC1392 • TA04.

PACKAGE DESCRIPTION

Dimensions in inches (millimeters) unless otherwise noted.

N8 Package 8-Lead Plastic DIP

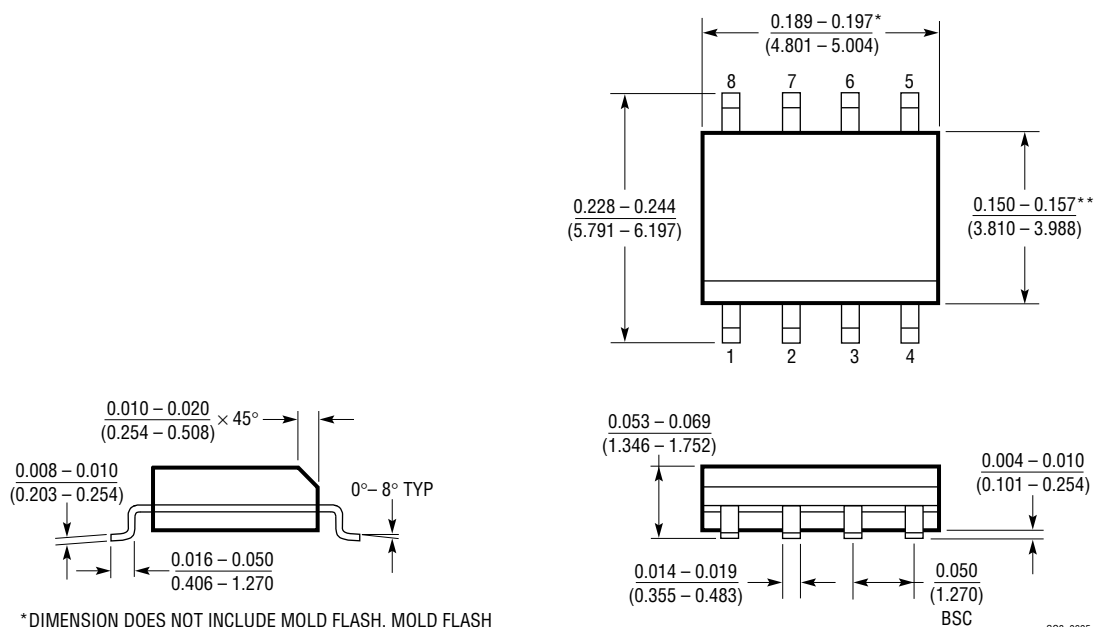


*THESE DIMENSIONS DO NOT INCLUDE MOLD FLASH OR PROTRUSIONS.
MOLD FLASH OR PROTRUSIONS SHALL NOT EXCEED 0.010 INCH (0.254mm)

PACKAGE DESCRIPTION

Dimensions in inches (millimeters) unless otherwise noted.

S8 Package 8-Lead Plastic SOIC



*DIMENSION DOES NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.006" (0.152mm) PER SIDE

**DIMENSION DOES NOT INCLUDE INTERLEAD FLASH. INTERLEAD FLASH SHALL NOT EXCEED 0.010" (0.254mm) PER SIDE

SD8 0695

RELATED PARTS

PART NUMBER	DESCRIPTION	COMMENT
LT1025	Micropower Thermocouple Cold Junction Compensator	Compatible with Standard Thermocouples (E, J, K, R, S, T)
LTC1285/LTC1288	3V Micropower 12-Bit ADC with Auto Shutdown	Differential or 2-Channel Multiplexed, Single Supply
LTC1286/LTC1298	Micropower 12-Bit ADC with Auto Shutdown	Differential or 2-Channel Multiplexed, Single Supply
LTC1390	Low Power, Precision 8-to-1 Analog Multiplexer	SPI, QSPI Compatible, Single 5V or 3V, Low R_{ON} , Low Charge Injection